

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	300	((atomic ADJ force ADJ microscope) or AFM) SAME contact) AND 73/105.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/26 11:49
L2	36	((atomic ADJ force ADJ microscope) or AFM) SAME contact) AND roughness AND 73/105.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/26 11:24
L3	69	((scanning ADJ force ADJ microscope) or AFM) SAME contact) AND roughness AND (73/105.ccls. or 250/306.ccls.)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/26 11:29
L4	90	((scanning ADJ probe ADJ microscope) or AFM) SAME contact) AND roughness AND (73/105.ccls. or 250/306.ccls.)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/26 11:37
L5	322	((atomic ADJ force ADJ microscope) or AFM) SAME contact) AND light AND (73/105.ccls. or 250/306.ccls.)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/26 11:49
S1	6071	roughness NEAR15 (paper or print\$5)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/24 17:53
S2	12931	((atomic ADJ force ADJ microscope) or AFM)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/24 17:54
S3	570	((atomic ADJ force ADJ microscope) or AFM) and 73/105.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/26 11:10